Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10569548	MAEHASHI ET AL.
Examiner	Art Unit
EDNA WONG	1795

SEARCHED				
Class	Subclass	Date	Examiner	
204	157.15	7/9/09	EW	
204	157.47	7/9/09	EW	
977	901	7/9/09	EW	

SEARCH NOTES				
Search Notes	Date	Examiner		
Inventor Search	7/9/09	EW		
EAST	7/9/09	EW		
STN	7/9/09	EW		
Search Updated	12/3/09	EW		
Pre-Appeal Conference with Nam Nguyen and Chris Fiorilla	4/26/10	EW		
Search Updated	5/9/10	EW		
Search Updated	9/3/10	EW		
Pre-Appeal Conference with Alexa Neckel and Shrive Beck	2/9/11	EW		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
204	157.15	2/13/11	EW
204	157.47	2/13/11	EW
977	901	2/13/11	EW

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